
	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 1(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

APPENDIX D: PROBE & DIPOLE CALIBRATION DATA

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		2(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

Calibration Laboratory of Schmid & Partner Engineering AG
 Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: **SCS 108**


Client **RTS (RIM Testing Services)**

Certificate No: **ES3-3225_Dec09**

CALIBRATION CERTIFICATE																																																			
Object	ES3DV3 - SN:3225																																																		
Calibration procedure(s)	QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2 Calibration procedure for dosimetric E-field probes																																																		
Calibration date:	December 11, 2009																																																		
<p>This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.</p> <p>All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.</p> <p>Calibration Equipment used (M&TE critical for calibration)</p> <table border="1"> <thead> <tr> <th>Primary Standards</th> <th>ID #</th> <th>Cal Date (Certificate No.)</th> <th>Scheduled Calibration</th> </tr> </thead> <tbody> <tr> <td>Power meter E4419B</td> <td>GB41293874</td> <td>1-Apr-09 (No. 217-01030)</td> <td>Apr-10</td> </tr> <tr> <td>Power sensor E4412A</td> <td>MY41495277</td> <td>1-Apr-09 (No. 217-01030)</td> <td>Apr-10</td> </tr> <tr> <td>Power sensor E4412A</td> <td>MY41498067</td> <td>1-Apr-09 (No. 217-01030)</td> <td>Apr-10</td> </tr> <tr> <td>Reference 3 dB Attenuator</td> <td>SN: S5054 (3c)</td> <td>31-Mar-09 (No. 217-01026)</td> <td>Mar-10</td> </tr> <tr> <td>Reference 20 dB Attenuator</td> <td>SN: S5086 (20b)</td> <td>31-Mar-09 (No. 217-01028)</td> <td>Mar-10</td> </tr> <tr> <td>Reference 30 dB Attenuator</td> <td>SN: S5129 (30b)</td> <td>31-Mar-09 (No. 217-01027)</td> <td>Mar-10</td> </tr> <tr> <td>Reference Probe ES3DV2</td> <td>SN: 3013</td> <td>2-Jan-09 (No. ES3-3013_Jan09)</td> <td>Jan-10</td> </tr> <tr> <td>DAE4</td> <td>SN: 660</td> <td>29-Sep-09 (No. DAE4-660_Sep09)</td> <td>Sep-10</td> </tr> </tbody> </table> <table border="1"> <thead> <tr> <th>Secondary Standards</th> <th>ID #</th> <th>Check Date (in house)</th> <th>Scheduled Check</th> </tr> </thead> <tbody> <tr> <td>RF generator HP 8648C</td> <td>US3642U01700</td> <td>4-Aug-99 (in house check Oct-09)</td> <td>In house check: Oct-11</td> </tr> <tr> <td>Network Analyzer HP 8753E</td> <td>US37390585</td> <td>18-Oct-01 (in house check Oct-09)</td> <td>In house check: Oct10</td> </tr> </tbody> </table>				Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration	Power meter E4419B	GB41293874	1-Apr-09 (No. 217-01030)	Apr-10	Power sensor E4412A	MY41495277	1-Apr-09 (No. 217-01030)	Apr-10	Power sensor E4412A	MY41498067	1-Apr-09 (No. 217-01030)	Apr-10	Reference 3 dB Attenuator	SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10	Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10	Reference 30 dB Attenuator	SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10	Reference Probe ES3DV2	SN: 3013	2-Jan-09 (No. ES3-3013_Jan09)	Jan-10	DAE4	SN: 660	29-Sep-09 (No. DAE4-660_Sep09)	Sep-10	Secondary Standards	ID #	Check Date (in house)	Scheduled Check	RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11	Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-09)	In house check: Oct10
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Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature 																																																
Approved by:	Name Kaşa Pokovic	Function Technical Manager	Signature 																																																
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Page 1 of 11

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		3(47)
Author Data	Dates of Test	Test Report No	FCC ID:
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**Calibration Laboratory of
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Glossary:


TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., θ = 0 is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}:** Assessed for E-field polarization θ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}:** A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		4(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

ES3DV3 SN:3225

December 11, 2009


Probe ES3DV3

SN:3225

Manufactured: September 1, 2009
 Calibrated: December 11, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		5(47)
Author Data	Dates of Test	Test Report No	FCC ID:
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ES3DV3 SN:3225

December 11, 2009

DASY - Parameters of Probe: ES3DV3 SN:3225

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$) ^A	1.26	1.22	1.32	± 10.1%
DCP (mV) ^B	92.3	94.8	92.7	

Modulation Calibration Parameters


UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc ^E (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	300.0	± 1.5%
			Y	0.00	0.00	1.00	300.0	
			Z	0.00	0.00	1.00	300.0	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter; uncertainty not required.

^E Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 6(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

ES3DV3 SN:3225


December 11, 2009

DASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	6.12	6.12	6.12	0.99	1.07 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.14	5.14	5.14	0.46	1.60 ± 11.0%
1950	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	4.96	4.96	4.96	0.47	1.57 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	4.53	4.53	4.53	0.41	1.89 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 7(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

ES3DV3 SN:3225


December 11, 2009

DASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	55.0 ± 5%	1.05 ± 5%	5.97	5.97	5.97	0.98	1.12 ± 11.0%
1810	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.90	4.90	4.90	0.35	2.07 ± 11.0%
1950	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.83	4.83	4.83	0.32	2.45 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	4.32	4.32	4.32	0.74	1.27 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

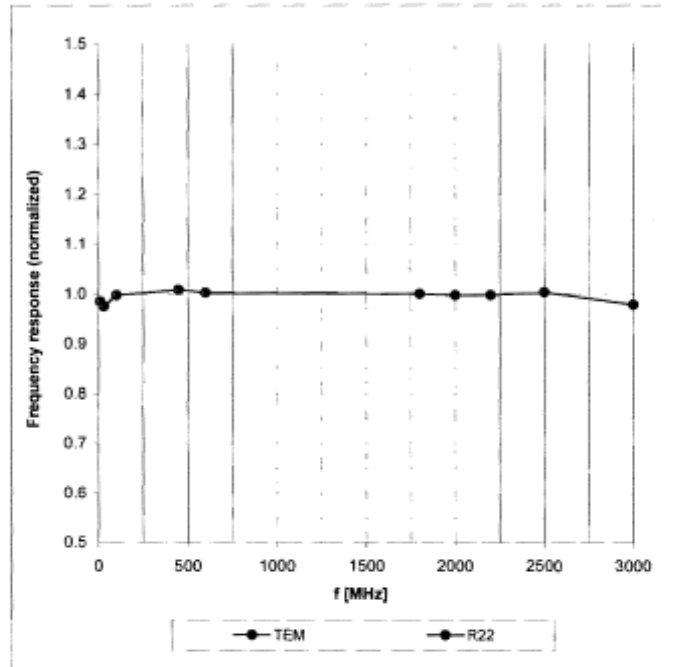
	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 8(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

ES3DV3 SN:3225


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Frequency Response of E-Field

(TEM-Cell: ifi110 EXX, Waveguide: R22)



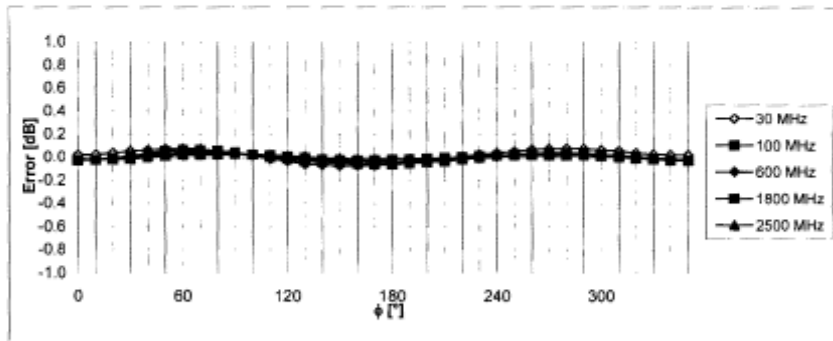
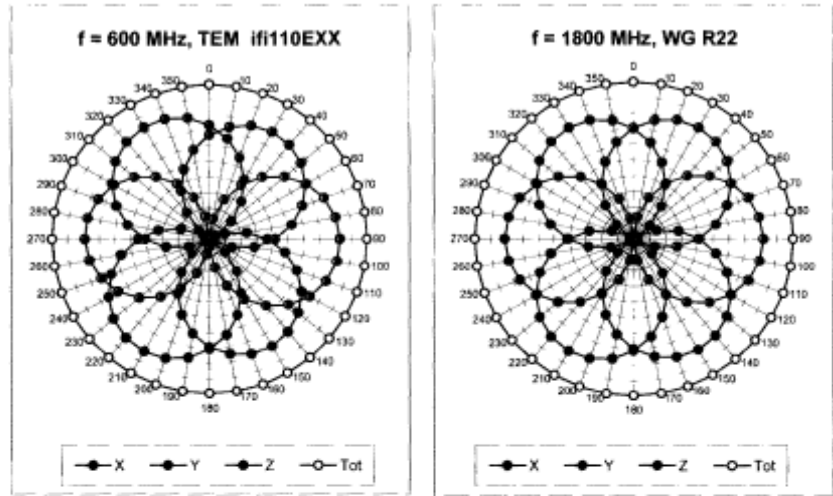
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 9(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25


ES3DV3 SN:3225

December 11, 2009

Receiving Pattern (ϕ), $\theta = 0^\circ$



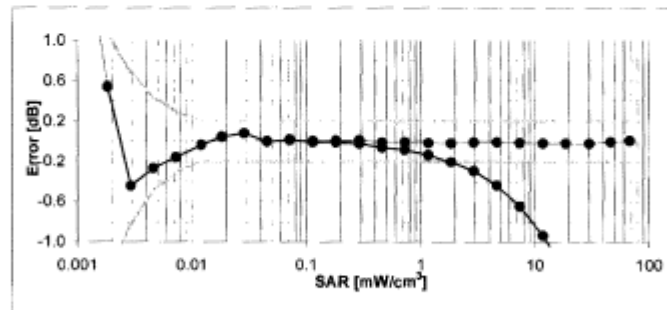
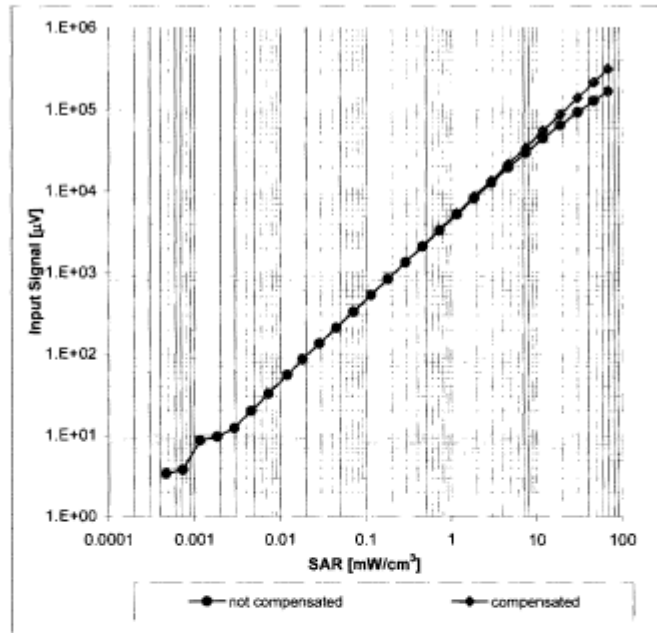
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 10(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25


ES3DV3 SN:3225

December 11, 2009

Dynamic Range f(SAR_{head}) (Waveguide R22, f = 1800 MHz)



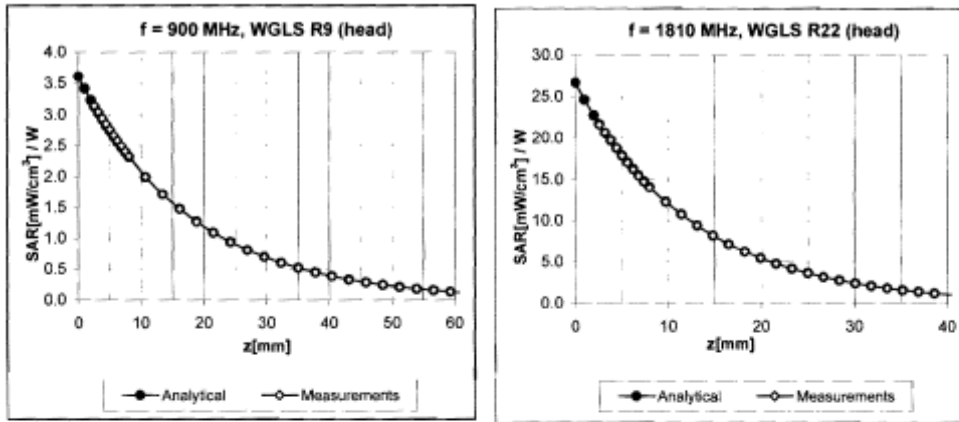
Uncertainty of Linearity Assessment: ± 0.6% (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 11(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

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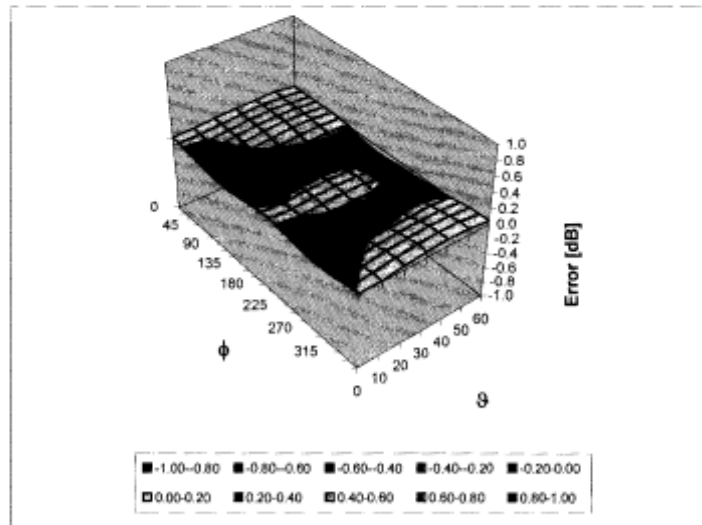
December 11, 2009

Conversion Factor Assessment




Deviation from Isotropy in HSL

Error (ϕ , θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)


	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		12(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

ES3DV3 SN:3225

December 11, 2009

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	4.0 mm
Probe Tip to Sensor X Calibration Point	2 mm
Probe Tip to Sensor Y Calibration Point	2 mm
Probe Tip to Sensor Z Calibration Point	2 mm
Recommended Measurement Distance from Surface	3 mm

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		13(47)
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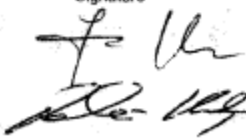
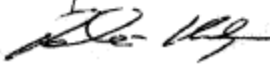
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Accreditation No.: **SCS 108**


Client **RTS (RIM Testing Services)**

Certificate No: **ET3-1644_Nov09**

CALIBRATION CERTIFICATE																																																			
Object	ET3DV6 - SN:1644																																																		
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Page 1 of 11

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		14(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

**Calibration Laboratory of
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 Zeughausstrasse 43, 8004 Zurich, Switzerland



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 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:


TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}:** Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}:** A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		15(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

ET3DV6 SN:1644

November 11, 2009


Probe ET3DV6

SN:1644

Manufactured: November 7, 2001
 Last calibrated: November 10, 2008
 Recalibrated: November 11, 2009

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		16(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

ET3DV6 SN:1644

November 11, 2009

DASY - Parameters of Probe: ET3DV6 SN:1644

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$) ^A	1.85	1.95	1.93	± 10.1%
DCP (mV) ^B	93.6	93.0	91.9	


Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	300	± 1.5%
			Y	0.00	0.00	1.00	300	
			Z	0.00	0.00	1.00	300	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		17(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

ET3DV6 SN:1644


November 11, 2009

DASY - Parameters of Probe: ET3DV6 SN:1644

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	6.08	6.08	6.08	0.42	2.29 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.17	5.17	5.17	0.61	2.31 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	4.50	4.50	4.50	0.99	1.61 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		18(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

ET3DV6 SN:1644


November 11, 2009

DASY - Parameters of Probe: ET3DV6 SN:1644

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
900	± 50 / ± 100	55.0 ± 5%	1.05 ± 5%	5.87	5.87	5.87	0.41	2.55 ± 11.0%
1810	± 50 / ± 100	53.3 ± 5%	1.52 ± 5%	4.69	4.69	4.69	0.79	2.57 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	1.95 ± 5%	4.11	4.11	4.11	0.99	1.41 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

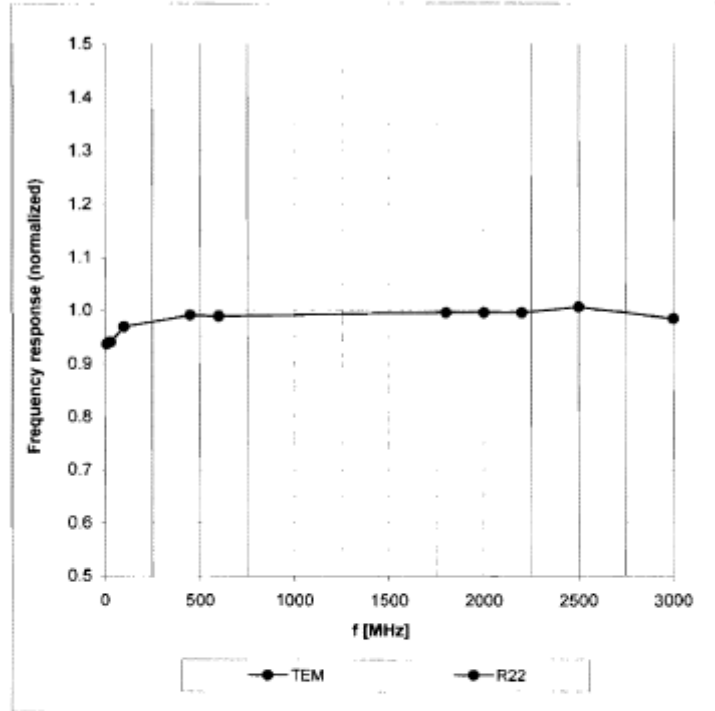
	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 19(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

ET3DV6 SN:1644


November 11, 2009

Frequency Response of E-Field

(TEM-Cell: ifi110 EXX, Waveguide: R22)



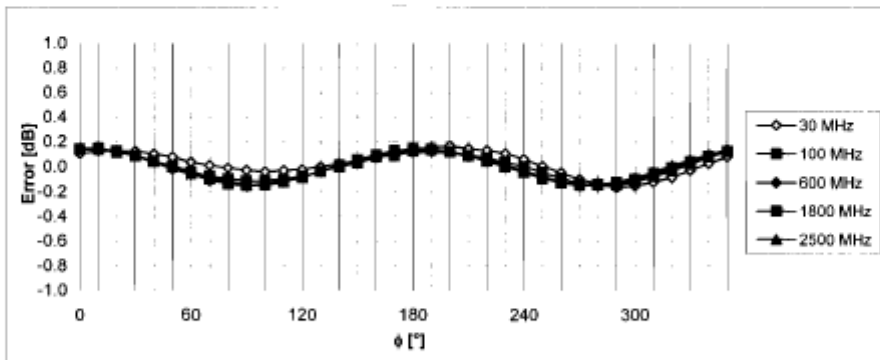
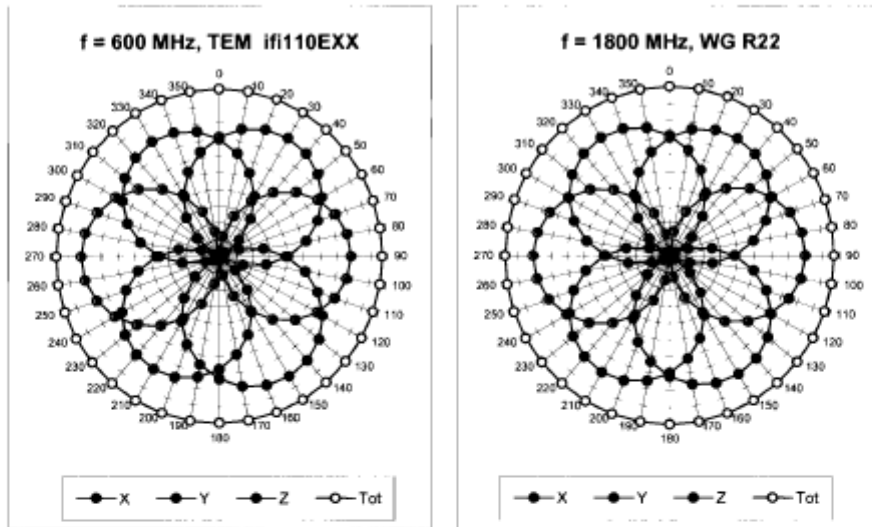
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 20(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25


ET3DV6 SN:1644

November 11, 2009

Receiving Pattern (ϕ), $\theta = 0^\circ$



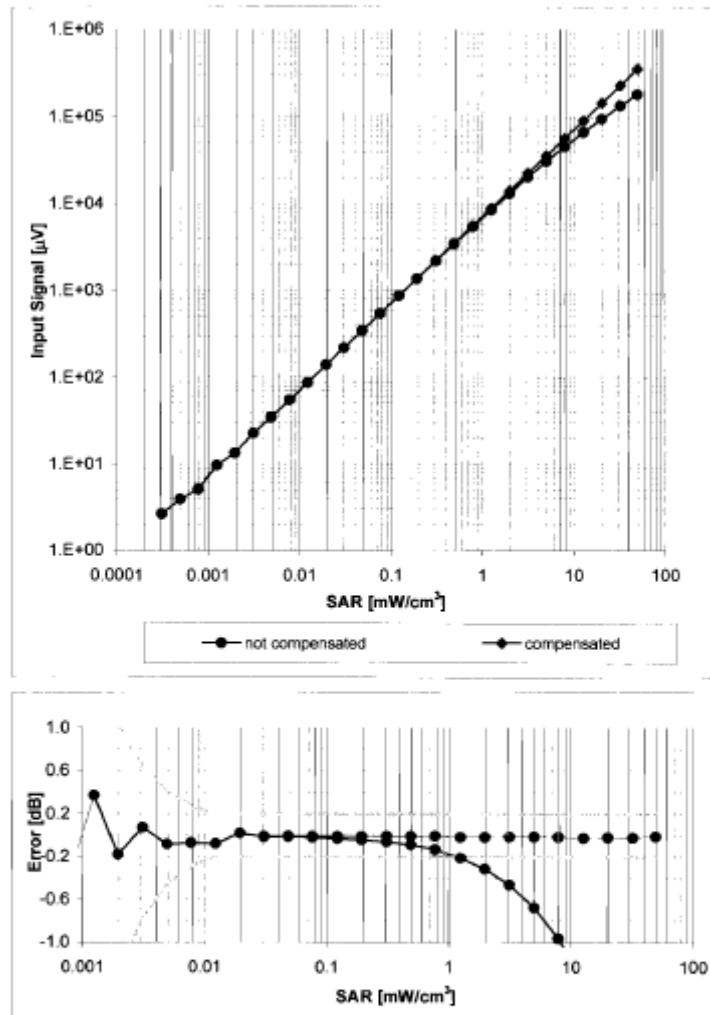
Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 21(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25


ET3DV6 SN:1644

November 11, 2009

Dynamic Range $f(SAR_{head})$ (Waveguide R22, $f = 1800$ MHz)



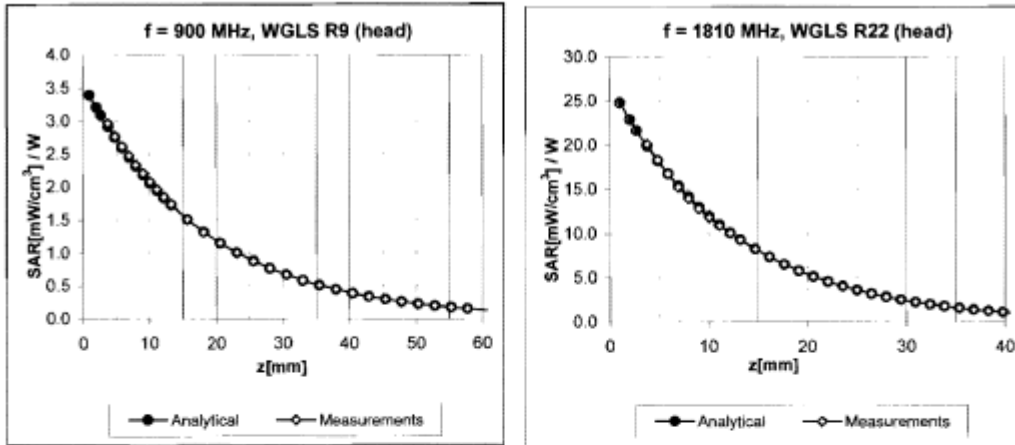
Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 22(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

ET3DV6 SN:1644

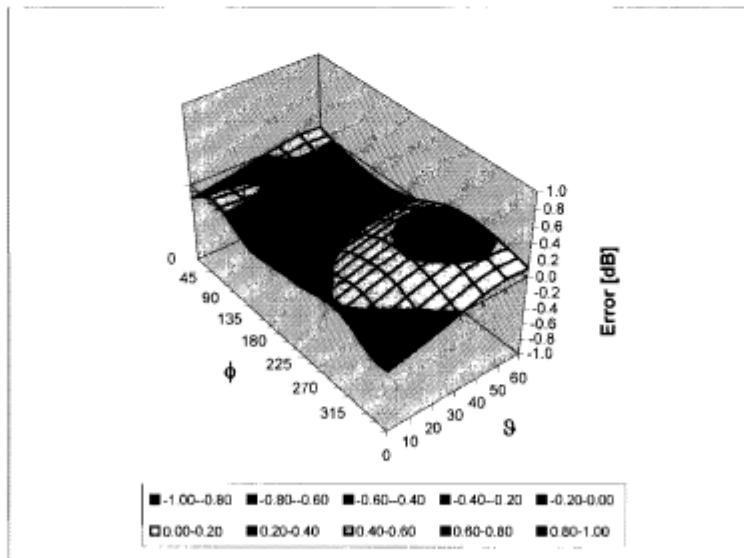
November 11, 2009

Conversion Factor Assessment




Deviation from Isotropy in HSL

Error (ϕ, θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)


	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		23(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

ET3DV6 SN:1644

November 11, 2009

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	enabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	6.8 mm
Probe Tip to Sensor X Calibration Point	2.7 mm
Probe Tip to Sensor Y Calibration Point	2.7 mm
Probe Tip to Sensor Z Calibration Point	2.7 mm
Recommended Measurement Distance from Surface	4 mm

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		24(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

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Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D835V2-446_Jan09**

CALIBRATION CERTIFICATE

Object **D835V2 - SN: 446**

Calibration procedure(s) **QA CAL-05.v7
Calibration procedure for dipole validation kits**

Calibration date: **January 05, 2009**

Condition of the calibrated item **In Tolerance**



This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)


Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: 5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: January 7, 2009

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	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		25(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

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Accreditation No.: **SCS 108**

Glossary:

TSL tissue simulating liquid
 ConvF sensitivity in TSL / NORM x,y,z
 N/A not applicable or not measured

Calibration is Performed According to the Following Standards:


- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 26(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.


	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.3 ± 6 %	0.91 mho/m ± 6 %
Head TSL temperature during test	(21.5 ± 0.2) °C	---	---

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.40 mW / g
SAR normalized	normalized to 1W	9.60 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	9.50 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.58 mW / g
SAR normalized	normalized to 1W	6.32 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	6.27 mW / g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		27(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	49.8 Ω - 6.9 jΩ
Return Loss	- 23.3 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.385 ns
----------------------------------	----------


After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	October 24, 2001

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 28(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

DASY5 Validation Report for Head TSL

Date/Time: 05.01.2009 10:38:06

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:446

Communication System: CW-835; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL 900 MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.91 \text{ mho/m}$; $\epsilon_r = 41.1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(5.97, 5.97, 5.97); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom 4.9L; Type: QD00P49AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

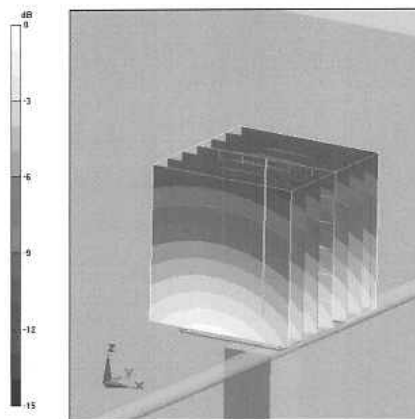
Pin=250mW; dip=15mm; dist=3.4mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.7 V/m; Power Drift = 0.024 dB


Peak SAR (extrapolated) = 3.54 W/kg

SAR(1 g) = 2.4 mW/g; SAR(10 g) = 1.58 mW/g

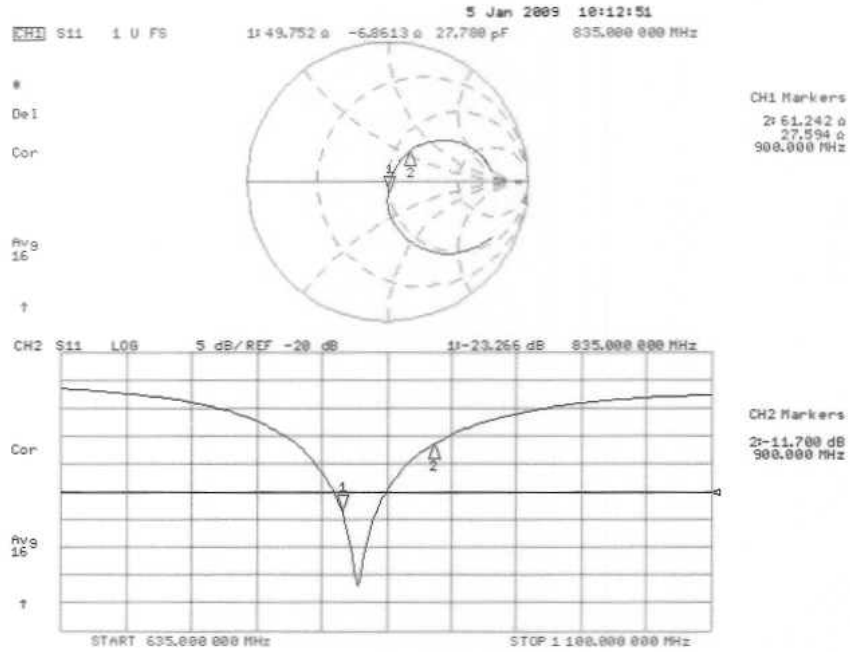
Maximum value of SAR (measured) = 2.7 mW/g




0 dB = 2.7mW/g

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 29(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

Impedance Measurement Plot for Head TSL



	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		30(47)
Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25	FCC ID: L6ARCX70UW

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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RTS (RIM Test Services)**

Certificate No: **D1800V2-2d020_Jan09**

CALIBRATION CERTIFICATE

Object **D1800V2 - SN: 2d020**

Calibration procedure(s) **QA CAL-05.v7
Calibration procedure for dipole validation kits**

Calibration date: **January 06, 2009**

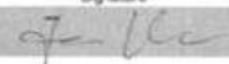

Condition of the calibrated item **In Tolerance**

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Reference 20 dB Attenuator	SN: 5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by:	Name Jeton Kastrál	Function Laboratory Technician	Signature 
Approved by:	Name Katja Pokovic	Technical Manager	

Issued: January 7, 2009

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	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		31(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

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Additional Documentation:

- d) DASy4/5 System Handbook

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- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		32(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1800 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.


	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.5 ± 6 %	1.40 mho/m ± 6 %
Head TSL temperature during test	(21.6 ± 0.2) °C	---	---

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	9.57 mW /g
SAR normalized	normalized to 1W	38.3 mW /g
SAR for nominal Head TSL parameters ¹	normalized to 1W	38.2 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.04 mW /g
SAR normalized	normalized to 1W	20.2 mW /g
SAR for nominal Head TSL parameters ¹	normalized to 1W	20.1 mW / g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		33(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	45.3 Ω - 7.5 $\mu\Omega$
Return Loss	- 20.6 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.215 ns
----------------------------------	----------


After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	September 07, 2001

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 34(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

DASY5 Validation Report for Head TSL

Date/Time: 06.01.2009 11:22:58

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1800 MHz; Type: D1800V2; Serial: SN:2d020

Communication System: CW; Frequency: 1800 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB

Medium parameters used: $f = 1800$ MHz; $\sigma = 1.4$ mho/m; $\epsilon_r = 39.6$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.96, 4.96, 4.96); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

Pin = 250 mW; dip = 10 mm, scan at 3.4mm 2/Zoom Scan (dist=3.4mm, probe 0deg)

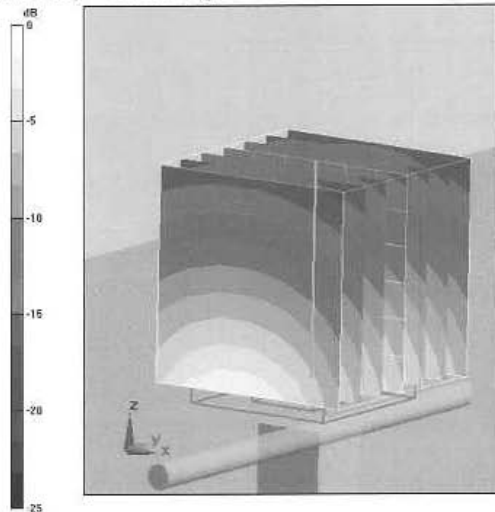
(7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 91.8 V/m; Power Drift = 0.036 dB


Peak SAR (extrapolated) = 17.6 W/kg

SAR(1 g) = 9.57 mW/g; SAR(10 g) = 5.04 mW/g

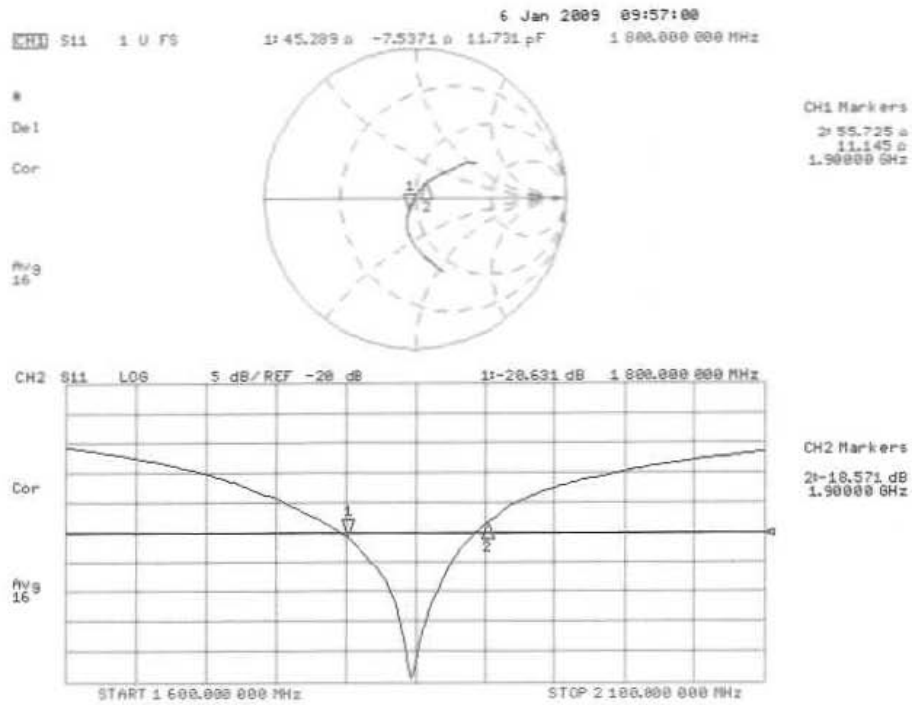
Maximum value of SAR (measured) = 11.2 mW/g




0 dB = 11.2mW/g

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 35(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

Impedance Measurement Plot for Head TSL



	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		36(47)
Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25	FCC ID: L6ARCX70UW

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Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D1900V2-545-Jan09**

CALIBRATION CERTIFICATE

Object: **D1900V2 - SN: 545**

Calibration procedure(s): **QA CAL-05.v7
Calibration procedure for dipole validation kits**

Calibration date: **January 06, 2009**

Condition of the calibrated item: **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)


Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: 5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by: **Jeton Kasrafi** (Name), **Laboratory Technician** (Function), *[Signature]* (Signature)

Approved by: **Ketja Pokovic** (Name), **Technical Manager** (Function), *[Signature]* (Signature)

Issued: January 7, 2009

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	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		37(47)
Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25	FCC ID: L6ARCX70UW

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Accreditation No.: **SCS 108**

Glossary:

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards:


- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		38(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.


	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.2 ± 6 %	1.47 mho/m ± 6 %
Head TSL temperature during test	(21.0 ± 0.2) °C	---	---

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	10.2 mW / g
SAR normalized	normalized to 1W	40.8 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	39.5 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	5.29 mW / g
SAR normalized	normalized to 1W	21.2 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	20.8 mW / g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		39(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	49.9 Ω + 1.9 j Ω
Return Loss	- 34.4 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.197 ns
----------------------------------	----------


After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	November 15, 2001

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		40(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

DASY5 Validation Report for Head TSL

Date/Time: 06.01.2009 13:17:58

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:545

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB

Medium parameters used: $f = 1900$ MHz; $\sigma = 1.47$ mho/m; $\epsilon_r = 39.4$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.9, 4.9, 4.9); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom: 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

Pin = 250 mW; dip = 10 mm, scan at 3.4mm/Zoom Scan (dist=3.4mm, probe 0deg)

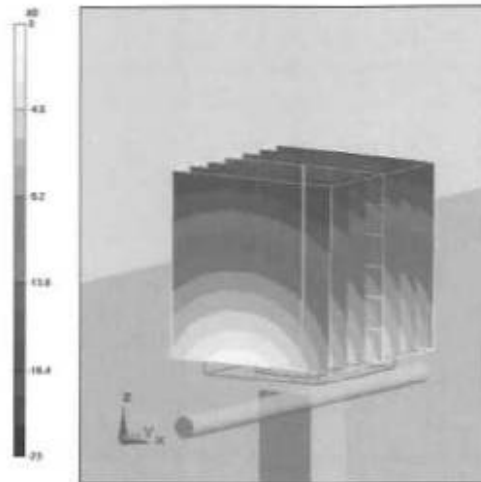
(7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 92.5 V/m; Power Drift = 0.037 dB


Peak SAR (extrapolated) = 19 W/kg

SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.29 mW/g

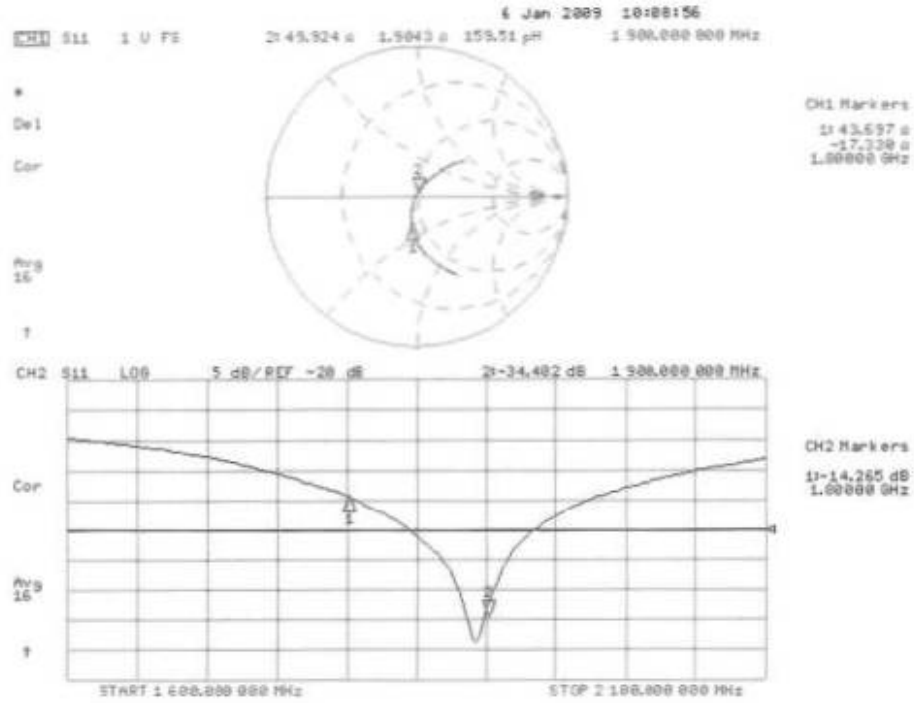
Maximum value of SAR (measured) = 12 mW/g




0 dB = 12mW/g

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 41(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

Impedance Measurement Plot for Head TSL



	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		42(47)
Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25	FCC ID: L6ARCX70UW

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 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **RTS (RIM Testing Services)**

Certificate No: **D2450V2-747 Nov09**

CALIBRATION CERTIFICATE

Object: **D2450V2 - SN: 747**

Calibration procedure(s): **QA CAL-05.v7
 Calibration procedure for dipole validation kits**

Calibration date: **November 11, 2009**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)


Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-09 (No. 217-01086)	Oct-10
Power sensor HP 8481A	US37292783	06-Oct-09 (No. 217-01086)	Oct-10
Reference 20 dB Attenuator	SN: 5086 (20g)	31-Mar-09 (No. 217-01025)	Mar-10
Type-N mismatch combination	SN: 5047.2 / 06327	31-Mar-09 (No. 217-01029)	Mar-10
Reference Probe ES3DV3	SN: 3205	26-Jun-09 (No. ES3-3205_Jun09)	Jun-10
DAE4	SN: 601	07-Mar-09 (No. DAE4-601_Mar09)	Mar-10
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-09)	In house check: Oct-10

Calibrated by: **Mike Meil** (Name), **Laboratory Technician** (Function), *[Signature]* (Signature)

Approved by: **Katja Pokovic** (Name), **Technical Manager** (Function), *[Signature]* (Signature)

Issued: November 16, 2009

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	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		43(47)
Author Data	Dates of Test	Test Report No	FCC ID:
Andrew Becker	March 15 – March 16, 2010	RTS-2474-1003-25	L6ARCX70UW

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Accreditation No.: **SCS 108**

Glossary:

TSL tissue simulating liquid
 ConvF sensitivity in TSL / NORM x,y,z
 N/A not applicable or not measured

Calibration is Performed According to the Following Standards:


- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- *Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

	Document		Page
	Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		44(47)
Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25	FCC ID: L6ARCX70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters


The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.1 ± 6 %	1.78 mho/m ± 6 %
Head TSL temperature during test	(21.3 ± 0.2) °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.3 mW / g
SAR normalized	normalized to 1W	53.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	53.4 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	6.23 mW / g
SAR normalized	normalized to 1W	24.9 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.9 mW /g ± 16.5 % (k=2)

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 45(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	51.9 Ω + 0.9 $j\Omega$
Return Loss	- 33.9 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.161 ns
----------------------------------	----------


After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	December 01, 2003

	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 46(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

DASY5 Validation Report for Head TSL

Date/Time: 11.11.2009 15:04:10

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:747

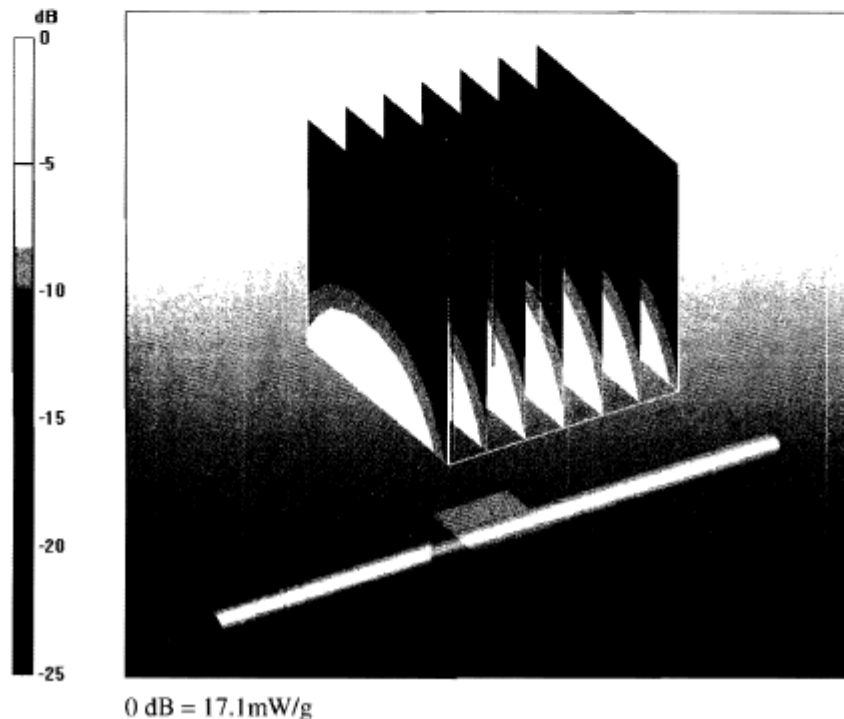
Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1
 Medium: HSL U11 BB
 Medium parameters used: $f = 2450 \text{ MHz}$; $\sigma = 1.79 \text{ mho/m}$; $\epsilon_r = 39.2$; $\rho = 1000 \text{ kg/m}^3$
 Phantom section: Flat Section
 Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)


DASY5 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(4.53, 4.53, 4.53); Calibrated: 26.06.2009
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 07.03.2009
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Head/d=10mm, Pin=250 mW, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) (7x7x7)/Cube 0:

Measurement grid: $dx=5\text{mm}$, $dy=5\text{mm}$, $dz=5\text{mm}$
 Reference Value = 101.3 V/m; Power Drift = 0.067 dB
 Peak SAR (extrapolated) = 27 W/kg
SAR(1 g) = 13.3 mW/g; SAR(10 g) = 6.23 mW/g
 Maximum value of SAR (measured) = 17.1 mW/g



	Document Appendix D for the BlackBerry® Smartphone Model RCX72UW SAR Report		Page 47(47)
	Author Data Andrew Becker	Dates of Test March 15 – March 16, 2010	Test Report No RTS-2474-1003-25

Impedance Measurement Plot for Head TSL

